

Search Notes (continued)

Application/Control No.

10/805,320

Examiner

Meless N. Zewdu

Applicant(s)/Patent under
Reexamination

KANAZAWA ET AL.

Art Unit

2617

SEARCHED

Class	Subclass	Date	Examiner
455	41.2-41.3	5/12/2006	M.Z.
455	404.1	5/12/2006	M.Z.
455	404.2	5/12/2006	M.Z.
455	421	5/12/2006	M.Z.
455	456.1	5/12/2006	M.Z.
455	456.3	5/12/2006	M.Z.
455	466	5/12/2006	M.Z.
455	67.11	5/12/2006	M.Z.
455	550.1	5/12/2006	M.Z.
455	556.1	5/12/2006	M.Z.
455	556.2	5/12/2006	M.Z.
455	557	5/12/2006	M.Z.
455	567	5/12/2006	M.Z.
455	574	5/12/2006	M.Z.

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
Please refer to the attached search history.		5/12/2006	M.Z.

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Consulted with Appiah, Charles.	4/10/2006	M.Z.
Consulted with Holloway, Edwin.	4/10/2006	M.Z.
Consulted with Lee, Benjamin.	4/11/2006	M.Z.
Searched US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT AND Ibm_tdb.	5/12/2006	M.Z.

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340	286.07	5/12/2006	M.Z.
340	539.12	5/12/2006	M.Z.
340	539.21	5/12/2006	M.Z.
340	539.23	5/12/2006	M.Z.
340	686.6	5/12/2006	M.Z.
340	573.1	5/12/2006	M.Z.
340	573.4	5/12/2006	M.Z.

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR